

Search Notes

Application/Control No.

10/750,845

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

KANG ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
430	191	6/2006	JSC
430	192	↓	↓
430	193		
430	326		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
UPDATED	6/2006	JSC